

Search Notes

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Examiner

Paul D. Kim

Applicant(s)/Patent under
Reexamination

GOUO, AKIO

Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	603.03 603.05 603.06	7/21/2005	PK
324	210	7/21/2005	PK
360	244.1 244.2	↓	
	245.8		

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Reviewed Parent Application 09/748,918 US PAT. 6,690,546	7/21/2005	PK
Text Search EAST/NPL (IEEE)	7/21/2005	PK